

# 10-MHz LOW-NOISE LOW-VOLTAGE LOW-POWER OPERATIONAL AMPLIFIERS

Check for Samples: LMV721, LMV722

#### **FEATURES**

Power-Supply Voltage Range: 2.2 V to 5.5 V

Low Supply Current: 930 μA/Amplifier at 2.2 V

High Unity-Gain Bandwidth: 10 MHz

Rail-to-Rail Output Swing

 600-Ω Load: 120 mV From Either Rail at 2.2 V

- 2-kΩ Load: 50 mV From Either Rail at 2.2 V

 Input Common-Mode Voltage Range Includes Ground

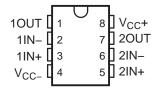
• Input Voltage Noise: 9 nV/ $\sqrt{Hz}$  at f = 1 kHz

#### **APPLICATIONS**

- Cellular and Cordless Phones
- Active Filter and Buffers
- Laptops and PDAs
- Battery Powered Electronics

# OUT [ 1 5 ] V<sub>CC+</sub> | 1N+ [ 3 4 ] IN-

## LMV722...D, DGK, OR DRG PACKAGE (TOP VIEW)



#### DESCRIPTION/ORDERING INFORMATION

The LMV721 (single) and LMV722 (dual) are low-noise low-voltage low-power operational amplifiers that can be designed into a wide range of applications. The LMV721 and LMV722 have a unity-gain bandwidth of 10 MHz, a slew rate of 5 V/ $\mu$ s, and a quiescent current of 930  $\mu$ A/amplifier at 2.2 V.

The LMV721 and LMV722 are designed to provide optimal performance in low-voltage and low-noise systems. They provide rail-to-rail output swing into heavy loads. The input common-mode voltage range includes ground, and the maximum input offset voltage are 3.5 mV (over recommended temperature range) for the devices. Their capacitive load capability is also good at low supply voltages. The operating range is from 2.2 V to 5.5 V.

#### ORDERING INFORMATION(1)

T <sub>A</sub>		PACKAGE <sup>(</sup>	2)	ORDERABLE PART NUMBER	TOP-SIDE MARKING (3)
		SC-70 – DCK	Reel of 3000	LMV721IDCKR	DK
	Single	3C-70 - DCK	Reel of 250	LMV721IDCKT	RK_
		SOT-23 - DBV	Reel of 3000	LMV721IDBVR	RBF_
-40°C to 105°C		SOIC D	Reel of 2500	LMV722IDR	M\/7221
	Dual	SOIC – D	Tube of 75	LMV722ID	MV722I
	Dual	VSSOP - DGK	Reel of 2500	LMV722IDGKR	R6_
		QFN – DRG	Reel of 2500	LMV722IDRGR	ZYY

<sup>(1)</sup> For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.



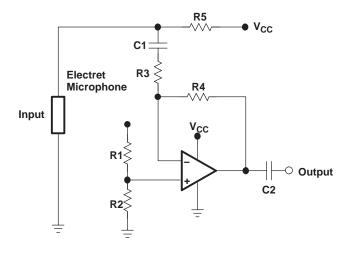
Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

<sup>(2)</sup> Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.

<sup>(3)</sup> DBV/DCK/DGK: The actual top-side marking has one additional character that designates the wafer fab/assembly site.



#### **Typical Application**



### Absolute Maximum Ratings(1)

over operating free-air temperature range (unless otherwise noted)

		•	MIN	MAX	UNIT
V <sub>CC+</sub> - V <sub>CC-</sub>	Supply voltage <sup>(2)</sup>			6	V
V <sub>ID</sub>	Differential input voltage (3)		±Supp	ly voltage	V
		D package <sup>(5)</sup>		97	
		DBV package <sup>(5)</sup>		206	
$\theta_{JA}$	Package thermal impedance (4)	DCK package <sup>(5)</sup>		252	°C/W
		DGK package <sup>(5)</sup>		172	
		DRG package <sup>(6)</sup>		50.7	
TJ	Operating virtual-junction temperature			150	°C
T <sub>stg</sub>	Storage temperature range		-65	150	°C

- (1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values (except differential voltages and V<sub>CC</sub> specified for the measurement of I<sub>OS</sub>) are with respect to the network GND.
- (3) Differential voltages are at IN+ with respect to IN-.
- (4) Maximum power dissipation is a function of T<sub>J</sub>(max), θ<sub>JA</sub>, and T<sub>A</sub>. The maximum allowable power dissipation at any allowable ambient temperature is P<sub>D</sub> = (T<sub>J</sub>(max) T<sub>A</sub>)/θ<sub>JA</sub>. Operating at the absolute maximum T<sub>J</sub> of 150°C can affect reliability.
- (5) The package thermal impedance is calculated in accordance with JESD 51-7.
- (6) The package thermal impedance is calculated in accordance with JESD 51-5.

#### **Recommended Operating Conditions**

		MIN	MAX	UNIT
$V_{CC+} - V_{CC-}$	Supply voltage	2.2	5.5	V
T <sub>J</sub>	Operating virtual-junction temperature	-40	105	°C

#### **ESD Protection**

	TYP	UNIT
Human-Body Model	2000	V
Machine Model	100	V

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#### **Electrical Characteristics**

 $V_{CC+}$  = 2.2 V,  $V_{CC-}$  = GND,  $V_{ICR}$  =  $V_{CC+}/2$ ,  $V_{Q}$  =  $V_{CC+}/2$ , and  $R_L$  > 1 M $\Omega$  (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	T <sub>J</sub>	MIN	TYP	MAX	UNIT	
V	Input offset voltage		25°C		0.02	3	mV	
V <sub>IO</sub>	input onset voltage		-40°C to 105°C			3.5	IIIV	
$TCV_IO$	Input offset voltage average drift		25°C		0.6		μV/°C	
$I_{IB}$	Input bias current		25°C		260		nA	
$I_{IO}$	Input offset current		25°C		25		nA	
CMMD	Common mode rejection ratio	V = 0.V to 1.2.V	25°C	70	88		dB	
CMMR	Common-mode rejection ratio	$V_{ICR} = 0 V \text{ to } 1.3 V$	-40°C to 105°C	64			uБ	
PSRR	Dower cumply rejection ratio	$V_{CC+} = 2.2 \text{ V to 5 V},$	25°C	80	90		٩D	
PSKK	Power-supply rejection ratio	$V_O = 0$ , $V_{ICR} = 0$	-40°C to 105°C	70			dB	
V	land to a second and the second	CMRR ≥ 50 dB	0500		-0.3		\ <i>I</i>	
$V_{ICR}$	Input common-mode voltage		25°C		1.3		V	
		$R_L = 600 \Omega$ ,		75	81			
•	Lanca standardo de manasta	$V_0 = 0.75 \text{ V to 2 V}$	-40°C to 105°C	70			.ID	
$A_{VD}$	Large-signal voltage gain	$R_1 = 2 k\Omega$	25°C	75	84		dB	
		$V_0 = 0.5 \text{ V to } 2.1 \text{ V}$	-40°C to 105°C	70				
		D 000 0 1 1/1 /0	25°C	2.090	2.125			
		$R_L = 600 \Omega \text{ to } V_{CC+}/2$	-40°C to 105°C	2.065				
			25°C		0.071	0.120		
			-40°C to 105°C			0.145		
$V_{O}$	Output swing	5 010 11 15	25°C	2.150	2.177		V	
		$R_L = 2 k\Omega$ to $V_{CC+}/2$	-40°C to 105°C	2.125				
			25°C		0.056	0.080		
			-40°C to 105°C			0.105		
		Sourcing, V <sub>O</sub> = 0 V,	25°C	10	14.9			
		$V_{IN(diff)} = \pm 0.5 \text{ V}$	-40°C to 105°C	5			mA	
lo	Output current	Sinking, $V_O = 2.2 \text{ V}$ ,	25°C	10	17.6			
		$V_{IN(diff)} = \pm 0.5 \text{ V}$	-40°C to 105°C	5				
			25°C		0.93	1.3		
		LMV721	-40°C to 105°C			1.5		
I <sub>CC</sub>	Supply current		25°C		1.81	2.4	mA	
		LMV722	-40°C to 105°C			2.6		
SR	Slew rate <sup>(1)</sup>		25°C		4.9		V/μs	
GBW	Gain bandwidth product		25°C		10		MHz	
Φ <sub>m</sub>	Phase margin		25°C		67.4		0	
G <sub>m</sub>	Gain margin		25°C		-9.8		dB	
V <sub>n</sub>	Input-referred voltage noise	f = 1 kHz	25°C		9		nV/√ <del>Hz</del>	
In	Input-referred current noise	f = 1 kHz	25°C		0.3		pA/√ <del>Hz</del>	
THD	Total harmonic distortion	$f = 1 \text{ kHz}, \text{ AV} = 1, \\ R_L = 600 \ \Omega, \text{ V}_O = 500 \ \text{mV}_{pp}$	25°C		0.004		%	

<sup>(1)</sup> Connected as voltage follower with 1-V step input. Number specified is the slower of the positive and negative slew rate.



#### **Electrical Characteristics**

 $V_{CC+}$  = 5 V,  $V_{CC-}$  = GND,  $V_{ICR}$  =  $V_{CC+}/2$ ,  $V_{O}$  =  $V_{CC+}/2$ , and  $R_L$  > 1 M $\Omega$  (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	T <sub>J</sub>	MIN	TYP	MAX	UNIT	
\/	Input offeet voltege		25°C		-0.08	3	m\/	
$V_{IO}$	Input offset voltage		-40°C to 105°C			3.5	mV	
$TCV_{IO}$	Input offset voltage average drift		25°C		0.6		μV/°C	
I <sub>IB</sub>	Input bias current		25°C		260		nA	
I <sub>IO</sub>	Input offset current		25°C		25		nA	
CMMD	Common mode rejection ratio	\/ 0\/ to 4.4\/	25°C	80	89		٩D	
CMMR	Common-mode rejection ratio	$V_{ICR} = 0 V to 4.1 V$	-40°C to 105°C	75			dB	
PSRR	Dower cumply rejection retic	$V_{CC+} = 2.2 \text{ V to 5 V},$	25°C	70	90		ID.	
FORK	Power-supply rejection ratio	$V_O = 0$ , $V_{ICR} = 0$	-40°C to 105°C	64			dB	
V	lanut common mode voltage	CMRR ≥ 50 dB	25%		-0.3		V	
$V_{ICR}$	Input common-mode voltage		25°C		4.1		V	
		$R_L = 600 \Omega$ ,		80	87			
^	Large signal valtage sain	$V_0^2 = 0.75 \text{ V to } 4.8 \text{ V}$	-40°C to 105°C	70			٩D	
$A_{VD}$	Large-signal voltage gain	$R_L = 2 k\Omega$	25°C	80	94		dB	
		$V_0 = 0.7 \text{ V to } 4.9 \text{ V}$	-40°C to 105°C	70				
		D 000 0 1 1/1 /0	25°C	4.84	4.882		-	
		$R_L = 600 \Omega \text{ to } V_{CC+}/2$	-40°C to 105°C	4.815				
			25°C		0.134	0.19		
			-40°C to 105°C			0.215	.,	
Vo	Output swing	2 212 11 12	25°C	4.93	4.952		V	
		$R_L = 2 k\Omega \text{ to } V_{CC+}/2$	-40°C to 105°C	4.905				
			25°C		0.076	0.11		
			-40°C to 105°C			0.135		
		Sourcing, $V_O = 0 V$ ,	25°C	20	52.6		_	
		$V_{IN(diff)} = \pm 0.5 V$	-40°C to 105°C	12				
l <sub>O</sub>	Output current	Sinking, $V_0 = 2.2 \text{ V}$ ,	25°C	15	23.7		mA	
		$V_{IN(diff)} = \pm 0.5 \text{ V}$	-40°C to 105°C	8.5				
		110/704	25°C		1.03	1.4		
		LMV721	-40°C to 105°C			1.7		
I <sub>CC</sub>	Supply current	111/700	25°C		2.01	2.4	mA	
		LMV722	-40°C to 105°C			2.8		
SR	Slew rate <sup>(1)</sup>		25°C		5.25		V/μs	
GBW	Gain bandwidth product		25°C		10		MHz	
Фт	Phase margin		25°C		72		0	
G <sub>m</sub>	Gain margin		25°C		-11		dB	
V <sub>n</sub>	Input-referred voltage noise	f = 1 kHz	25°C		8.5		nV/√ <del>Hz</del>	
In	Input-referred current noise	f = 1 kHz	25°C		0.2		pA/√ <del>Hz</del>	
THD	Total harmonic distortion	f = 1  kHz,  AV = 1, $R_L = 600 \ \Omega, \text{ V}_O = 500 \ \text{mV}_{pp}$	25°C		0.001		%	

<sup>(1)</sup> Connected as voltage follower with 1-V step input. Number specified is the slower of the positive and negative slew rate.



1.4

1.3

1.2

1.1

1 0.9

0.8

0.7 0.6 0.5

0.4

2

2.5

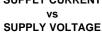
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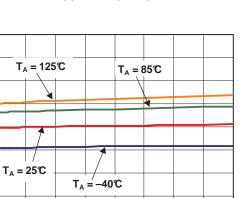
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Icc - Supply Current - mA

#### **TYPICAL CHARACTERISTICS**

## **SUPPLY CURRENT**





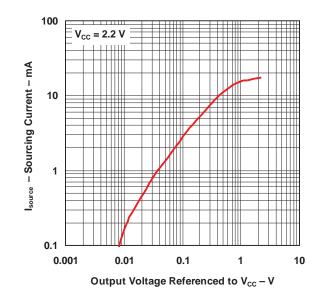
4.5

5

5.5

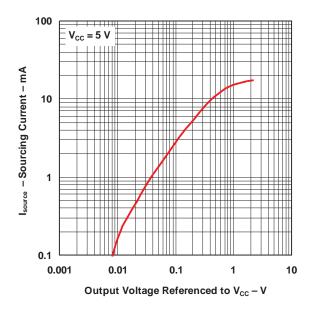
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**SOURCING CURRENT OUTPUT VOLTAGE** 

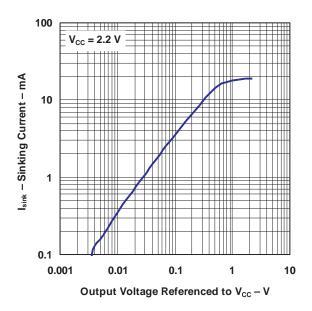


**SOURCING CURRENT OUTPUT VOLTAGE** 

V<sub>cc</sub> - Supply Voltage - V



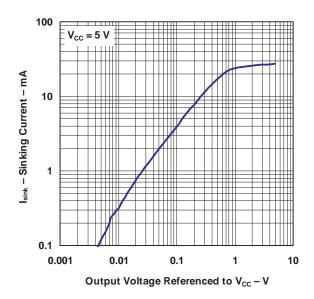
SINKING CURRENT **OUTPUT VOLTAGE** 



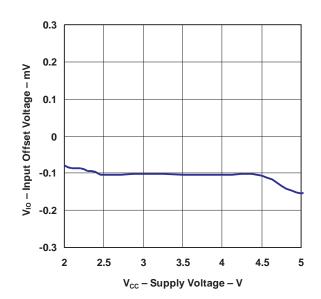


#### **TYPICAL CHARACTERISTICS (continued)**

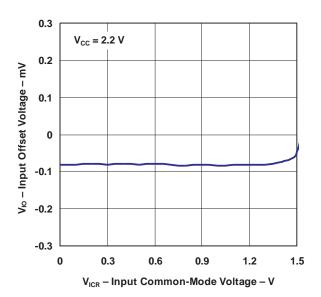
# SINKING CURRENT vs OUTPUT VOLTAGE



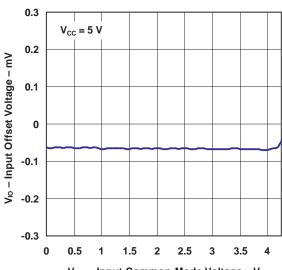
OUTPUT VOLTAGE SWING
vs
SUPPLY VOLTAGE



INPUT OFFSET VOLTAGE
vs
INPUT COMMON-MODE VOLTAGE



# INPUT OFFSET VOLTAGE vs INPUT COMMON-MODE VOLTAGE



 $V_{ICR}$  – Input Common-Mode Voltage – V

 $V_{CC} = 5 V$ 

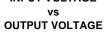
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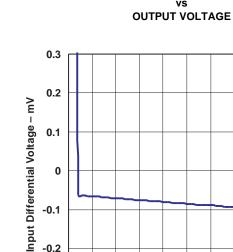
**INPUT VOLTAGE** 



#### **TYPICAL CHARACTERISTICS (continued)**







0.1

0

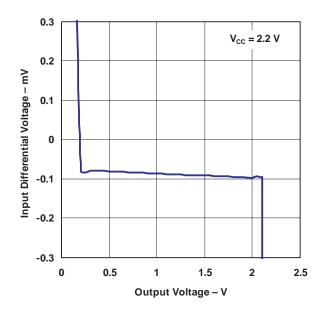
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-0.2

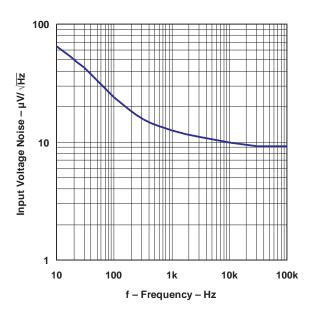
-0.3

0

0.5 1



**INPUT VOLTAGE NOISE FREQUENCY** 

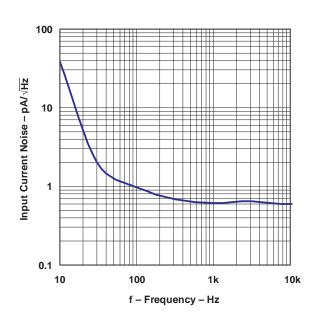


**INPUT CURRENT NOISE FREQUENCY** 

Output Voltage - V

3 3.5

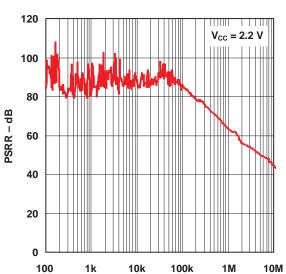
1.5 2 2.5



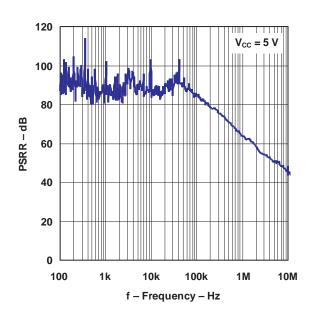


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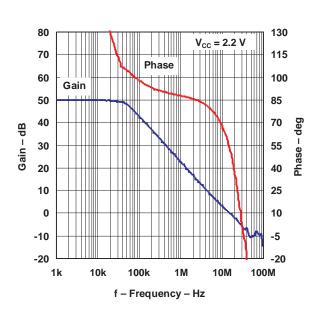


PSRR vs FREQUENCY

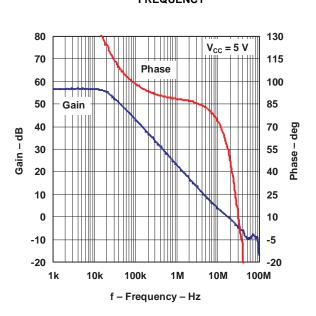


GAIN AND PHASE vs FREQUENCY

f - Frequency - Hz



GAIN AND PHASE vs FREQUENCY



4.4

4.2

4

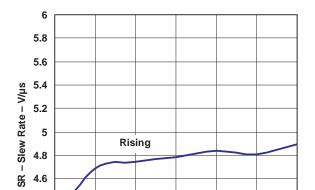
2

2.5



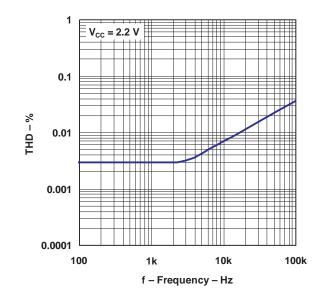
#### **TYPICAL CHARACTERISTICS (continued)**

#### SLEW RATE vs SUPPLY VOLTAGE



**Falling** 

THD vs FREQUENCY



#### **PULSE RESPONSE**

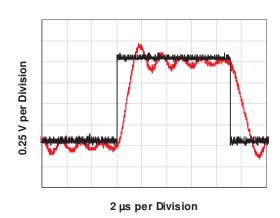
3.5

V<sub>cc</sub> - Supply Voltage - V

4.5

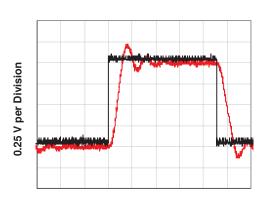
5

$$\mbox{V}_{\mbox{\scriptsize cc}}$$
 = 5 V,  $\mbox{R}_{\mbox{\tiny L}}$  = 2 k $\Omega,$   $\mbox{C}_{\mbox{\tiny L}}$  = 21.2 nF,  $\mbox{R}_{\mbox{\scriptsize o}}$  = 0  $\Omega$ 



#### **PULSE RESPONSE**

$$\mbox{V}_{\mbox{\scriptsize cc}}$$
 = 5 V,  $\mbox{R}_{\mbox{\tiny L}}$  = 2 k $\Omega,$   $\mbox{C}_{\mbox{\tiny L}}$  = 21.2 nF,  $\mbox{R}_{\mbox{\scriptsize o}}$  = 2.1  $\Omega$ 



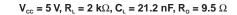
2 µs per Division

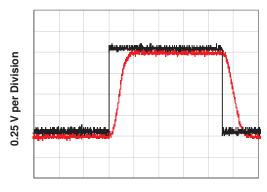
## TEXAS INSTRUMENTS

#### TYPICAL CHARACTERISTICS (continued)

#### **PULSE RESPONSE**

#### SE RESPONSE PULSE

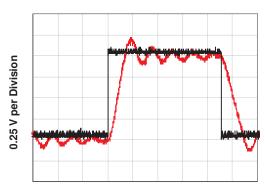




2 µs per Division

#### **PULSE RESPONSE**

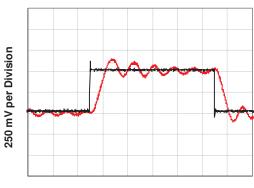
$$\mbox{V}_{\mbox{\scriptsize cc}}$$
 = 5 V,  $\mbox{R}_{\mbox{\tiny L}}$  = 600  $\Omega,$   $\mbox{C}_{\mbox{\tiny L}}$  = 21.2 nF,  $\mbox{R}_{\mbox{\tiny O}}$  = 0  $\Omega$ 



2 µs per Division

#### **PULSE RESPONSE**

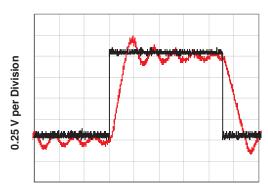
$$V_{cc}$$
 = 2.2 V,  $R_{\scriptscriptstyle L}$  = 2 k $\Omega$ ,  $C_{\scriptscriptstyle L}$  = 2.12 nF,  $R_{\scriptscriptstyle O}$  = 0  $\Omega$ 



1 µs per Division

#### **PULSE RESPONSE**

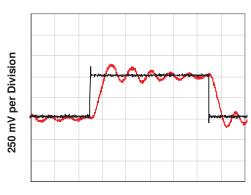
$$\mbox{V}_{\mbox{\tiny CC}}$$
 = 5 V,  $\mbox{R}_{\mbox{\tiny L}}$  = 10 k $\Omega,$   $\mbox{C}_{\mbox{\tiny L}}$  = 21.2 nF,  $\mbox{R}_{\mbox{\tiny O}}$  = 0  $\Omega$ 



2 µs per Division

#### **PULSE RESPONSE**

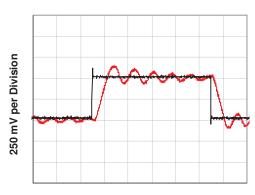
$$V_{cc}$$
 = 2.2 V,  $R_{L}$  = 2  $\Omega$ ,  $C_{L}$  = 2.12 nF,  $R_{o}$  = 0  $\Omega$ 



1 µs per Division

#### **PULSE RESPONSE**

$$\mbox{V}_{\mbox{\scriptsize cc}}$$
 = 2.2 V,  $\mbox{R}_{\mbox{\tiny L}}$  = 10 k $\Omega$ ,  $\mbox{C}_{\mbox{\tiny L}}$  = 2.12 nF,  $\mbox{R}_{\mbox{\scriptsize o}}$  = 0  $\Omega$ 



1 µs per Division



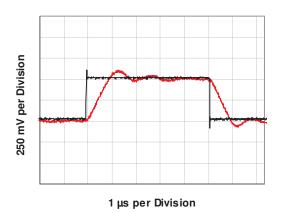
#### **TYPICAL CHARACTERISTICS (continued)**

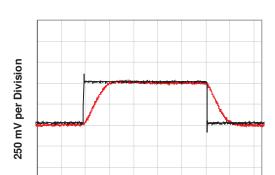
#### **PULSE RESPONSE**

#### **PULSE RESPONSE**

 $\mbox{V}_{\mbox{\tiny CC}}$  = 2.2 V,  $\mbox{R}_{\mbox{\tiny L}}$  = 10 k $\Omega,$   $\mbox{C}_{\mbox{\tiny L}}$  = 2.12 nF,  $\mbox{R}_{\mbox{\tiny O}}$  = 11.5  $\Omega$ 

 $\mbox{V}_{\mbox{\scriptsize cc}}$  = 2.2 V,  $\mbox{R}_{\mbox{\tiny L}}$  = 10 k $\Omega,$   $\mbox{C}_{\mbox{\tiny L}}$  = 2.12 nF,  $\mbox{R}_{\mbox{\scriptsize o}}$  = 2.2  $\Omega$ 

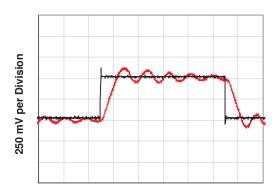




1 µs per Division

#### **PULSE RESPONSE**

$$\mbox{V}_{\mbox{\scriptsize cc}}$$
 = 2.2 V,  $\mbox{R}_{\mbox{\tiny L}}$  = 600  $\Omega,$   $\mbox{C}_{\mbox{\tiny L}}$  = 1.89 nF,  $\mbox{R}_{\mbox{\scriptsize o}}$  = 0  $\Omega$ 



1 µs per Division



#### **REVISION HISTORY**

CI	hanges from Revision B (August 2010) to Revision C	Page
•	Changed all temperature parameters from max of 85°C to 105°C	1
•	Changed supply voltage max value to 6 in Absolute Maximum Ratings table	2
•	Changed supply voltage MAX value to 5.5 in Recommended Operating Conditions table	2
•	Changed $A_{VD}$ , $V_O$ test conditons for $R_L$ = 600 $\Omega$ : 0.75 V to 4.8 V	4
•	Changed A <sub>VD</sub> , V <sub>O</sub> test conditons for R <sub>L</sub> = 2 k $\Omega$ $\Omega$ : 0.75 V to 4.8 V	4

www.ti.com 2-May-2025

#### PACKAGING INFORMATION

Orderable	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
part number	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
LMV721IDBVR	Active	Production	SOT-23 (DBV)   5	3000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	(RBFA, RBFM)
LMV721IDCKR	Active	Production	SC70 (DCK)   5	3000   LARGE T&R	Yes	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 105	(RKA, RKM)
						NIPDAUAG			
LMV721IDCKT	Active	Production	SC70 (DCK)   5	250   SMALL T&R	Yes	NIPDAU   NIPDAUAG	Level-1-260C-UNLIM	-40 to 105	(RKA, RKM)
LMV722ID	Active	Production	SOIC (D)   8	75   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	MV722I
LMV722IDGKR	Active	Production	VSSOP (DGK)   8	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	R6E
LMV722IDR	Active	Production	SOIC (D)   8	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 105	MV722I

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

### **PACKAGE OPTION ADDENDUM**

www.ti.com 2-May-2025

#### OTHER QUALIFIED VERSIONS OF LMV722:

Automotive : LMV722-Q1

NOTE: Qualified Version Definitions:

• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

## **PACKAGE MATERIALS INFORMATION**

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#### TAPE AND REEL INFORMATION



# TAPE DIMENSIONS + K0 - P1 - B0 W Cavity - A0 -

	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

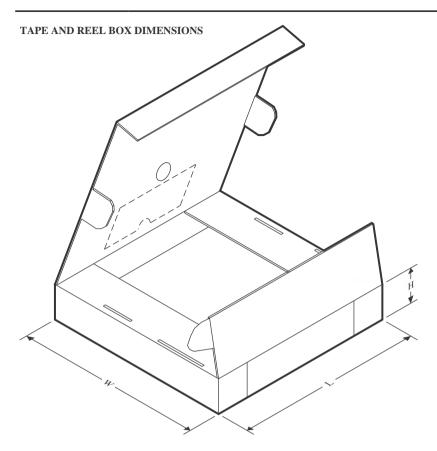


#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LMV721IDBVR	SOT-23	DBV	5	3000	178.0	9.0	3.23	3.17	1.37	4.0	8.0	Q3
LMV721IDCKR	SC70	DCK	5	3000	180.0	8.4	2.3	2.5	1.2	4.0	8.0	Q3
LMV721IDCKT	SC70	DCK	5	250	178.0	9.0	2.4	2.5	1.2	4.0	8.0	Q3
LMV721IDCKT	SC70	DCK	5	250	180.0	8.4	2.47	2.3	1.25	4.0	8.0	Q3
LMV722IDGKR	VSSOP	DGK	8	2500	330.0	12.4	5.3	3.3	1.3	8.0	12.0	Q1
LMV722IDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1



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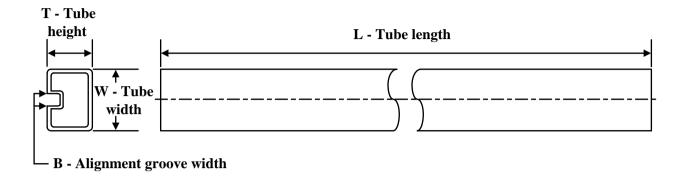
#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LMV721IDBVR	SOT-23	DBV	5	3000	180.0	180.0	18.0
LMV721IDCKR	SC70	DCK	5	3000	210.0	185.0	35.0
LMV721IDCKT	SC70	DCK	5	250	180.0	180.0	18.0
LMV721IDCKT	SC70	DCK	5	250	202.0	201.0	28.0
LMV722IDGKR	VSSOP	DGK	8	2500	346.0	346.0	35.0
LMV722IDR	SOIC	D	8	2500	353.0	353.0	32.0

## **PACKAGE MATERIALS INFORMATION**

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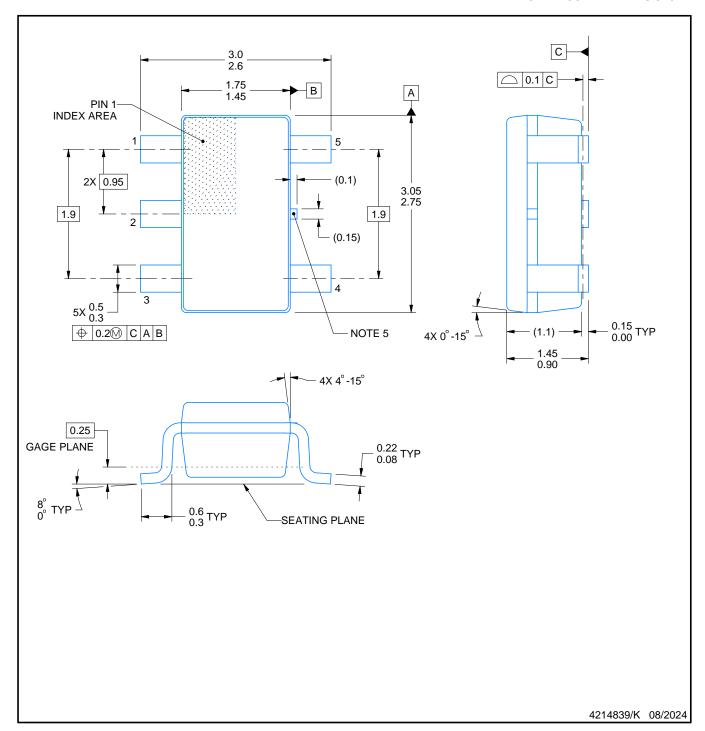
#### **TUBE**



#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
LMV722ID	D	SOIC	8	75	507	8	3940	4.32



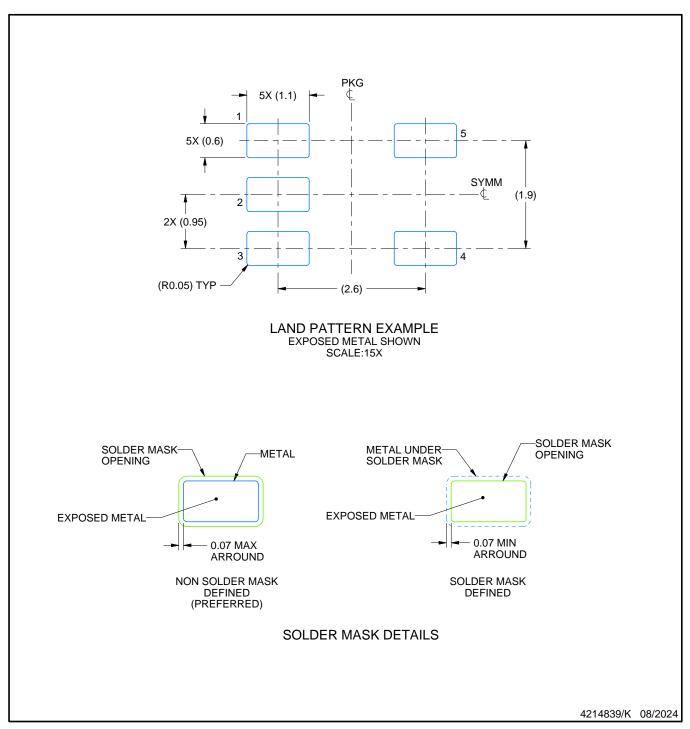


#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  2. This drawing is subject to change without notice.
  3. Reference JEDEC MO-178.

- 4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.
- 5. Support pin may differ or may not be present.



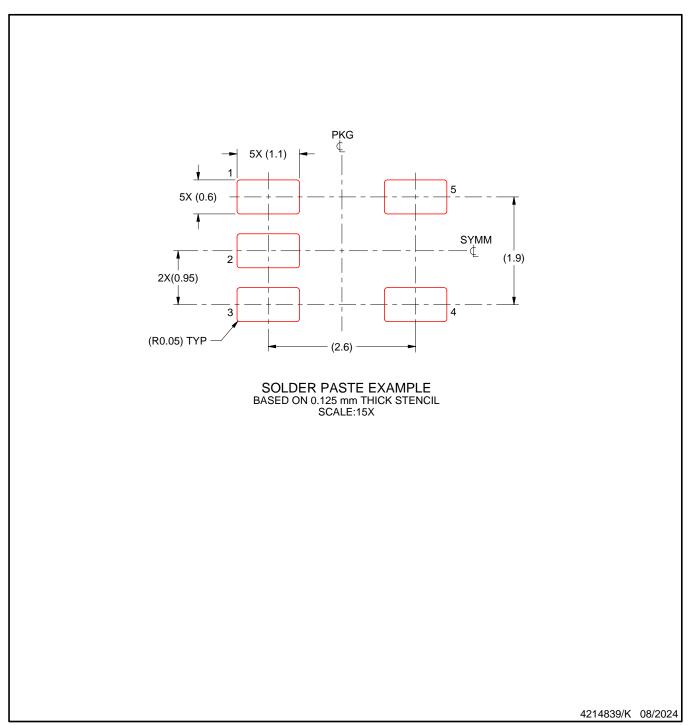


NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





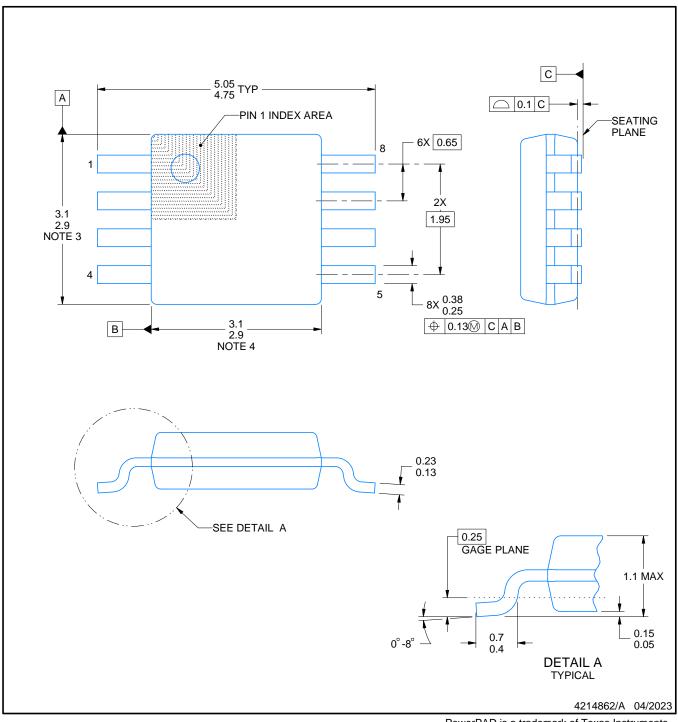
NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.





SMALL OUTLINE PACKAGE



#### NOTES:

PowerPAD is a trademark of Texas Instruments.

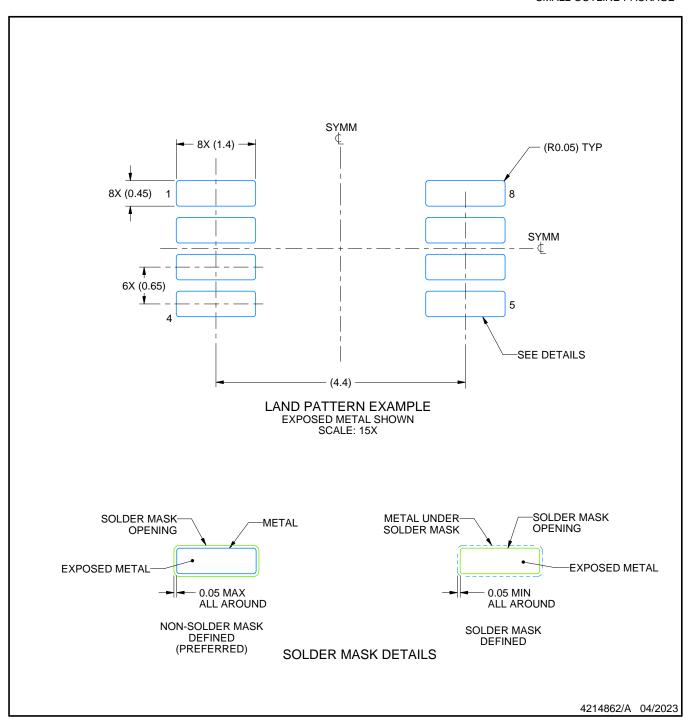
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-187.



SMALL OUTLINE PACKAGE

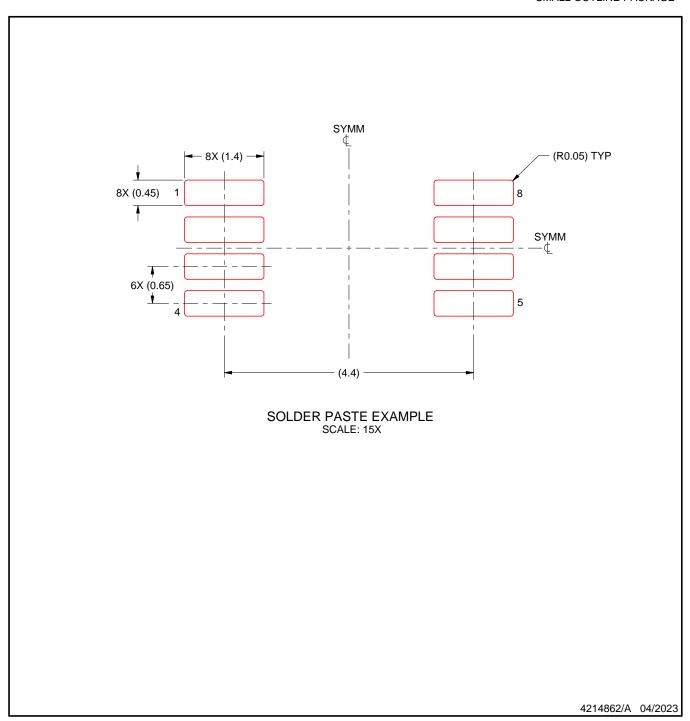


NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
- 8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
- 9. Size of metal pad may vary due to creepage requirement.



SMALL OUTLINE PACKAGE

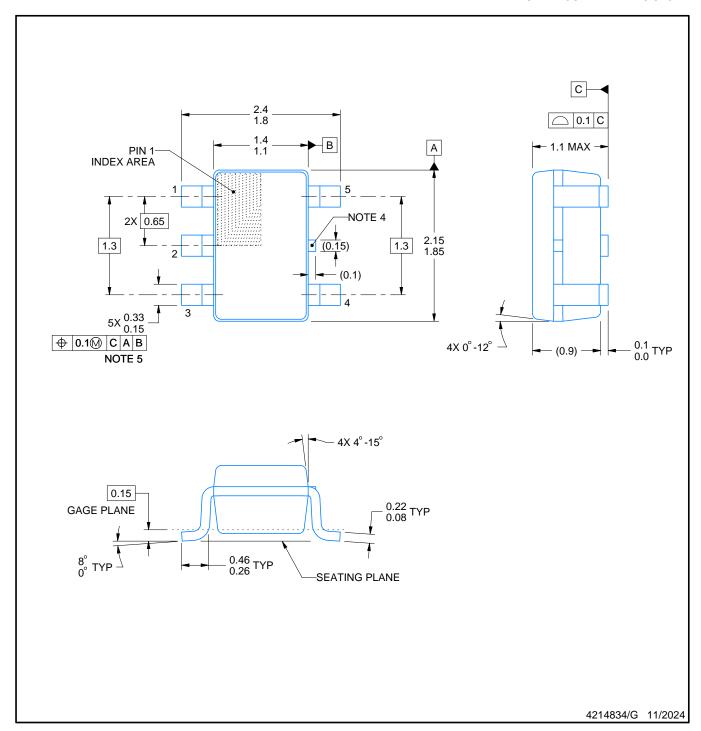


NOTES: (continued)

- 11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 12. Board assembly site may have different recommendations for stencil design.





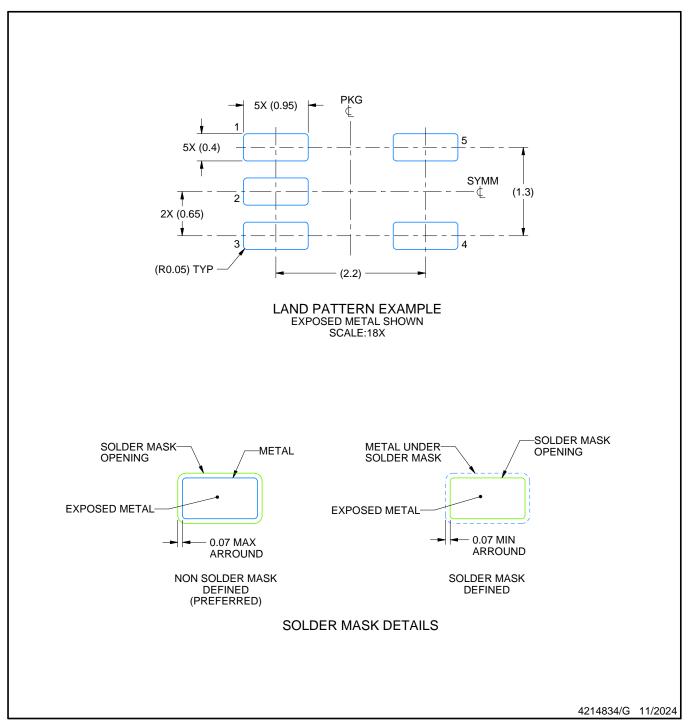


#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  2. This drawing is subject to change without notice.
  3. Reference JEDEC MO-203.

- 4. Support pin may differ or may not be present.5. Lead width does not comply with JEDEC.
- 6. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25mm per side

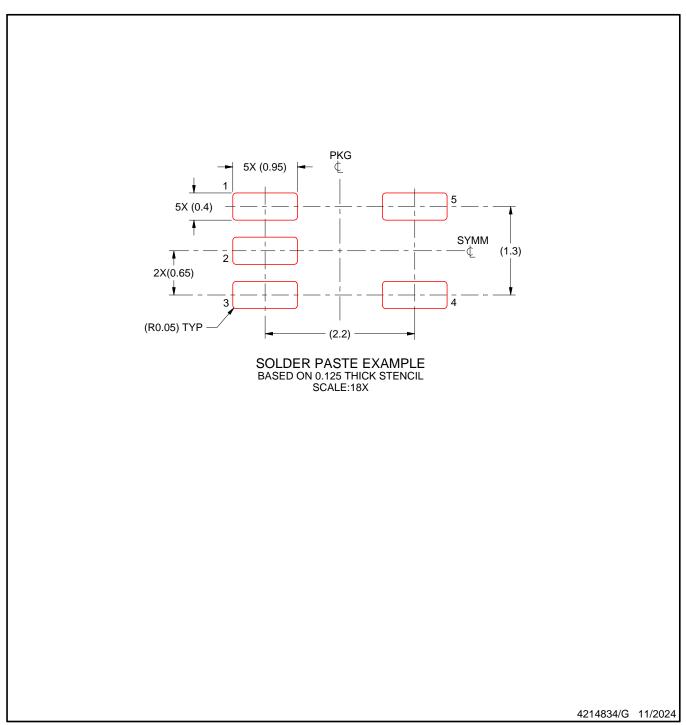




NOTES: (continued)

7. Publication IPC-7351 may have alternate designs.8. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 9. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 10. Board assembly site may have different recommendations for stencil design.





SMALL OUTLINE INTEGRATED CIRCUIT



#### NOTES:

- 1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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